

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10595157	TAKENAKA ET AL.
	Examiner	Art Unit
	John L Goff	1791

SEARCHED

Class	Subclass	Date	Examiner
156	307.1,307.7	7/31/08	JLG
Above	UPDATED	1/21/09	JLG
Above	UPDATED	6/1/09	JLG
Above	UPDATED	12/22/09	JLG

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	7/31/08	JLG
Palm Inventor Search	7/31/08	JLG
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	6/1/09	JLG

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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